

Notice of References Cited	Application/Control No. 10/802,205	Applicant(s)/Patent Under Reexamination LEU ET AL.	
	Examiner Lynne Edmondson	Art Unit 1725	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,230,458	07-1993	Asanasavest, Chainarong	228/102
*	B	US-5,176,310	01-1993	Akiyama et al.	228/180.5
*	C	US-5,637,947	06-1997	Kising et al.	310/316.01
*	D	US-4,485,957	12-1984	Sugimoto et al.	228/4.5
*	E	US-2005/0061848	03-2005	Johansen, David K.	228/001.1
*	F	US-5,890,643	04-1999	Razon et al.	228/1.1
*	G	US-5,400,503	03-1995	Komoriya et al.	29/850
*	H	US-6,302,317	10-2001	Narita et al.	228/254
*	I	US-6,093,904	07-2000	Haji, Hiroshi	219/121.45
*	J	US-5,357,423	10-1994	Weaver et al.	700/28
*	K	US-4,824,005	04-1989	Smith, Jr., Hal W.	228/1.1
*	L	US-4,571,688	02-1986	Kashihara et al.	700/212
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 04078147 A	03-1992	Japan	MATSUMOTO, ITARU	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.